

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/815,446	BODE ET AL.	
	Examiner Dwin M. Craig	Art Unit 2123	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (Please see the search notes for the search terms)	7/21/2005	JM
IEEE (Field Mean Error, wafer error)	7/21/2005	DNL
PALM (Inventor Name Search)	7/22/2005	DNL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner